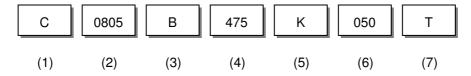


1. Scope

This specification is applied to Multilayer Ceramic Chip Capacitor(MLCC) for use in electric equipment for the voltage is ranging from 4V to 50V.

The series suitable for general electrics circuit, telecommunications, personal computers and peripheral, power circuit and mobile application. (This product is compliant with the RoHS.)

2. Parts Number Code



(1)Product

Product Code	
С	Multilayer Ceramic Chip Capacitor

(2)Chip Size

Code	Length×Width	unit : mm(inch)
0805	2.00× 1.25	(.079× .049)

(3)Temperature Characteristics

Code	Temperature	Temperature	Temperature
	Characteristic	Range	Coefficient
В	X5R	-55℃~+85℃	± 15%

(4)Capacitance unit :pico farads(pF)

Code	Nominal Capacitance (pF)
475	4,700,000.0

※. If there is a decimal point, it shall be expressed by an English capital letter R

(5) Capacitance Tolerance

Code	Tolerance	Nominal Capacitance
K	± 10.0 %	More Than 10 pF

(6)Rated Voltage

Code	Rated Voltage (Vdc)
050	50

(7)Tapping

Code	Type
T	Tape & Reel

3. Nominal Capacitance and Tolerance

3.1 Standard Combination of Nominal Capacitance and Tolerance

Class	Characteristic	Tolerance	Nominal Capacitance
П	X5R	K (± 10.0 %)	E-3, E-6 series

3.2 E series(standard Number)

Standard No.	Application Capacitance											
E- 3	1.0				2.2			4.7				
E- 6	1.0		1.5 2.2		3.3		4.7		6.8			
E-12	1.0	1.2	1.5	1.8	2.2	2.7	3.3	3.9	4.7	5.6	6.8	8.2
E-24	1.0	1.2	1.5	1.8	2.2	2.7	3.3	3.9	4.7	5.6	6.8	8.2
	1.1	1.3	1.6	2.0	2.4	3.0	3.6	4.3	5.1	6.2	7.5	9.1

4. Operation Temperature Range

Class	Characteristic	Temperature Range	Reference Temp.
П	X5R (B)	-55℃ ~ +85℃	25℃

5. Storage Condition

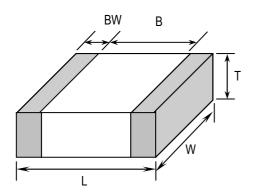
Storage Temperature : 5 to 40° C Relative Humidity : 20 to 70 % Storage Time : 12 months max.

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6. Dimensions

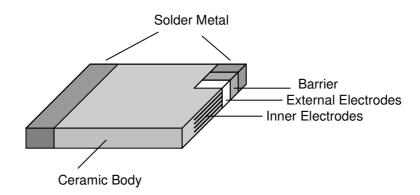
6.1 Configuration and Dimension:



Unit:mm

TYPE	L	W	Т	B (min)	BW (min)
0805	2.00± 0.20	1.25± 0.20	1.25± 0.20	0.70	0.20

6.2 Termination Type:



NCC-015-1509

7. Performance

No.	Iten	n	Speci	fication	Test Condition		
1	Visu	al	No abnormal exterior	appearance	Visual Inspection	1	
2	Dimen	sion	See Page 2		Visual Inspection		
3	3 Insulation Resistance				Applied Voltage: Rated Voltage Charge Time: 60±5 sec. Charge-Discharge current shall be less than 50mA current.		
4	Capacit	ance	Within The Specified	Tolerance	Class II ∶		
5	Tan δ	Class	X5R: 10% max.		Freq	uency	Voltage
		П			X5R	1KHz±10%	1.0±0.2Vrms or 0.5±0.2Vrms
					then place room	•	
6	Withstanding No dielectric breakdown or mechanical Voltage breakdown				250% of the rated charge/discharge	d voltage for 1~5 s Current is less th	sec. ian 50mA.
7	Temperature Capacitance Coefficient	Class Ⅱ	Char. Temp. Range X5R -55°C ~+85°C				erature(25°ℂ)
8	Adhesive Strength Of Termination No indication of peeling shall occur on the terminal electrode.				e applied for 10± 10.5 Kg·f) = 1.0 Kg·f)	I second.	
9	to a	ppear- nce	No mechanical dan change more than	The board shall mm/sec.	be bend 1.0mm v	vith a rate of 1.0	
	Flexure of Substrate	C-Meter	Capacitance Change Char. Cap. Change X5R (B) ≤ ± 12.5% of initial value		45±1mm	leter 45±1mm	Bending Limit

NCC-015-1509

No.	o. Item Specification			pecification		Test Condition	
10	Solderability		More than 90% of the terminal surface is to be soldered newly, so metal part does not come out or dissolve.		Solder Temperature : 245±5°C Dip Time : 5 ± 0.5sec Immersing Speed : 25±10% mm/s Solder : Lead Free Solder Flux :Rosin Preheat : At 80~120 °C for 10~30sec.		
11	Resistance To Soldering Heat	Appear- ance Capacit- ance Tan δ Class II Insulation Resistance	No mechanical damage shall occur. Class II ≤ ±7.5% of initial value X5R X5R: 10% max. To satisfy the specified initial value		Class II capacitor shall be set for 48±4 hours at room temperature after one hour heat treatment at 150 ± 0/-10 °C before initial measure. Preheat: at 150± 10 °C for 60~120sec. Dip: solder temperature of 260± 5 °C Dip Time: 10 ± 1sec. Immersing Speed: 25±10% mm/s Flux: Rosin Measure at room temperature after cooling for Class II: 48 ± 4 Hours		
12	Tempera ture Cycle	Appear- ance Capacit- ance Tan δ Class II Insulation Resistance	No mechanical damage shall occur. Class II ≤ ±7.5% of initial value X5R X5R:10% max. To satisfy the specified initial value		Class II capacitor shall be set for 48±4 hours a room temperature after one hour heat treatment at 150 +0/-10°C before initial measure. Capacitor shall be subjected to five cycles of the temperature cycle as following: Step Temp.(°C) Time(min) Min Rated Temp. +0/-3 30		
10	Llumidity	Annous	No machanical dam			25 Max Rated Temp. +3/-0 25 ure at room temperature a II : 48 ± 4 Hours	
13	Humidity			Cap. Change ≤ ±12.5% of initial value	Class II capacitor shall be set for 48± 4 at room temperature after one hour heat treatment at 150 +0/-10 °C before initial measure. Temperature: 40± 2°C Relative Humidity: 90 ~ 95%RH Test Time: 500 Hrs Max		our heat re initial
		Resistance				ure at room temperature a Ⅱ : 48 ± 4 Hours	itter cooling for

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NCC-015-1509

No.	Item		Specification		Test Condition		
14	Humidity Load	Appear- ance	<u> </u>		Class II capacitors applied DC voltage of the rated voltage is applied for one hour at maximu		
		Capacit- ance	C.GOO H	Cap. Change ≤ ±12.5% of initial value	operation temperature ± 3°C then shall be set for 48± 4 hours at room temperature and the initial		
		Tan δ	X5R X5R:20% max.		measurement shall be conducted. Applied Voltage :Rated Voltage Temperature : 40± 2°C		
		Class II Insulation 25/C Ω min. Resistance		Relative Humidity: 90 ~ 95%RH Test Time: 500 Hrs Max Current Applied: 50 mA Max.			
					Measure at room temperature after cooling for Class II: 48 ± 4 Hours		
15	High Temperature	Appear- ance	No mechanical damaç	ge shall occur.	The capacitors applied DC testing voltage is applied for one hour at maximum operation		
	Load (Life Test)	Capacit- ance	Characteristic Class II	Cap. Change ≤ ±12.5% of initial value	temperature ±3°C then shell be set for 48± 4 hours at room temperature and the initial		
			X5R		measurement shall be conducted. Applied Voltage: Rated Voltage		
		Tan δ Class	X5R:20% max.		Temperature: max. operation temperature Test Time: 1000 Hrs Max		
	Insulation 50/C Ω Resistance		50/C Ω min.		Current Applied: 50mA Max Measure at room temperature after cooling for Class II: 48 ± 4 Hours		
16	Vibration	Appear- ance	No mechanical damaç	ge shall occur	Solder the capacitor on P.C. board.		
		Capacit- ance	Within the specified tolerance		Vibrate the capacitor with amplitude of 1.5mm P-P changing the frequencies from 10Hz to 55Hz and back to 10Hz		
		Tan δ To satisfy the specified initial value Class ${\rm II}$		ied initial value	in about 1 min.		
		Insulation Resistance	To satisfy the specif	ied initial value	Repeat this for 2 hours each in 3 perpendicular directions.		

Note:

14010.	
	OUR STANDARD MEASURING INSTRUMENT
MEASURING INSTRUMENT	*C≦10uf
	4278A 1KHZ/1MHZ CAPACITANCE METER (Agilent)
	*C>10uf
	4284A 120HZ/1KHZ CAPACITANCE METER (Agilent)
MEASURING MODE	PARALLEL MODE
RECOMMENDED MEASURING JIG	HP 16334E TEST FIXTURE (Agilent)
STANDARD ENVIRONMENT	Temperature 25°C
	Relate Humidity 50±2%

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Fig.1
P.C. Board for Bending Strength Test

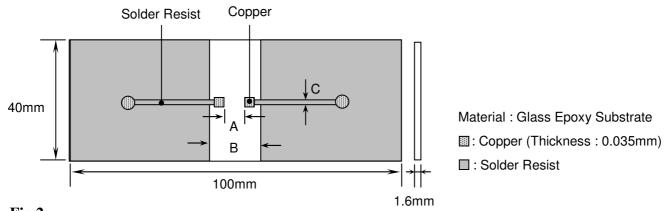
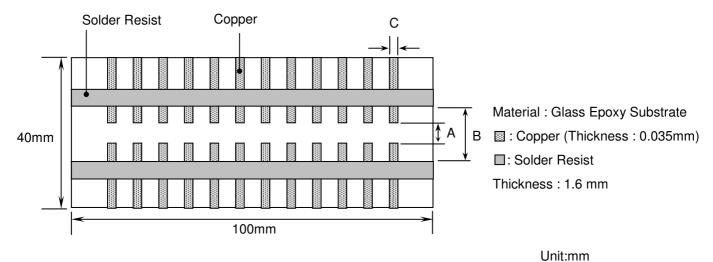


Fig.2
Test Substrate



Туре	А	В	С
0201	0.2	0.9	0.4
0402	0.5	1.5	0.6
0603	1.0	3.0	1.0
0805	1.2	4.0	1.6
1206	2.2	5.0	2.0
1210	2.2	5.0	2.9
1808	3.5	7.0	2.5
1812	3.5	7.0	3.7
2208	4.5	8.0	2.5
2211	4.5	8.0	3.0
2220	4.5	8.0	5.6

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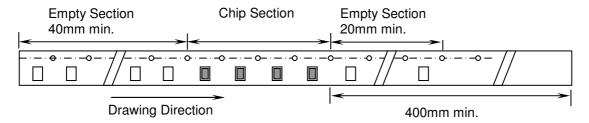


8. Packing

8.1 Bulk Packing

According to customer request.

8.2 Chip Capacitors Tape Packing



8.3 Material And Quantity

Tape	0201	0402	0603/0805		
Material	T≦0.33mm	T≦0.55mm	T≦0.90mm	T>0.90mm	
Paper	15,000 pcs/Reel	10,000 pcs/Reel	4,000 pcs/Reel	NA	
Plastic	NA	NA	NA	3,000 pcs/Reel	

Tape	1206					
Material	T≦0.90mm	0.90mm < T ≦ 1.25mm	T>1.25mm			
Paper	4,000 pcs/Reel	NA	NA			
Plastic	NA	3,000 pcs/Reel	2,000 pcs/Reel			

Tape	1808/1210					
Material	T≦1.25mm	1.25 mm $<$ T \leq 2.40 mm	T>2.40mm			
Paper	NA	NA	NA			
Plastic	3000 pcs/Reel	2000 pcs/Reel	500/1,000 pcs/Reel			

Tape	1812/22	11/2220	1825	2208	
Material	T≦2.20mm	T>2.20mm	T≦2.20mm	T>2.20mm	T≦2.20mm
Paper	NA	NA	NA	NA	NA
Plastic	1000 pcs/Reel	700 pcs/Reel	700 pcs/Reel	400 pcs/Reel	1000 pcs/Reel

NA: Not Available

8.4 Cover Tape Reel Off Force

8.4.1 Peel-Off Force

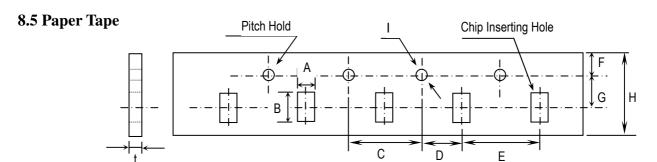
 $5 g \cdot f \leq Peel-Off Force \leq 70 g \cdot f$

8.4.2 Measure Method



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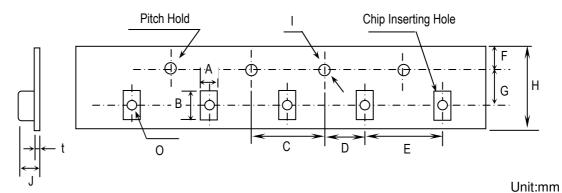


Unit:mm

TYPE	Α	В	С	D	E
0201	0.37± 0.1	0.67± 0.1	4.00± 0.1	2.00± 0.05	2.00± 0.1
0402	0.61± 0.1	1.20± 0.1			
0603	1.10± 0.2	1.90± 0.2			4.00± 0.1
0805	1.50± 0.2	2.30± 0.2			
1206	1.90± 0.2	3.50± 0.2			
1210	2.90± 0.2	3.60± 0.2			

TYPE	F	G	Н		t
0201	1.75± 0.10	3.50± 0.05	8.0± 0.30	φ 1.50 +0.10/-0	1.10 max.
0402					
0603					
0805					
1206					
1210					

8.6 Plastic Tape



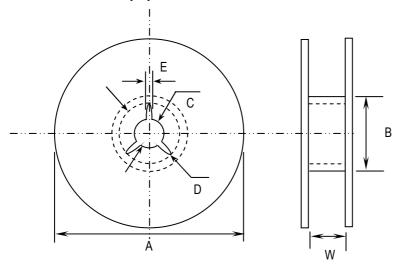
Type	Α	В	С	D	E	F
0805	1.5±0.2	2.3±0.2	4.0± 0.1	2.0± 0.05	4.0± 0.1	1.75± 0.1
1206	1.9±0.2	3.5±0.2				
1210	2.9±0.2	3.6±0.2				
1808	2.5±0.2	4.9±0.2				
1812	3.6±0.2	4.9±0.2			8.0± 0.1	
1825	6.9±0.2	4.9±0.2				
2208	2.5±0.2	6.1±0.2				
2211	3.2±0.2	6.1±0.2				
2220	5.4±0.2	6.1±0.2				
2225	6.9±0.2	6.1±0.2				



Туре	G	Н		J	t	0
0805	3.5± 0.05	8.0± 0.3	φ 1.5+0.1/-0	3.0 max.	0.3 max.	1.0± 0.1
1206						
1210						
1808	5.5± 0.05	12.0 ± 0.3		4.0 max.		1.5± 0.1
1812						
1825						
2208						
2211						
2220						
2225						

8.7 Reel Dimensions

Reel Material : Polystyrene



Unit:mm

Type	Α	В	С	D	E	W
0201	φ 382 max	arphi 50 min	φ 13± 0.5	φ 21± 0.8	2.0±0.5	10± 0.15
0402						
0603						
0805						
1206						
1210						
1808	φ 178±0.2	φ 60±0.2				13±0.3
1812						
1825						
2208						
2211						
2220						
2225						



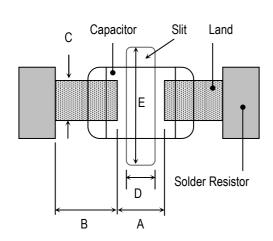
Precautionary Notes:

1. Storage

Store the capacitors where the temperature and relative humidity don't exceed 40 °C and 70%RH. We recommend that the capacitors be used within 12 months from the date of manufacturing. Store the products in the original package and do not open the outer wrapped, polyethylene bag, till just before usage. If it is open, seal it as soon as possible or keep it in a desiccant with a desiccation agent.

2. Construction of Board Pattern

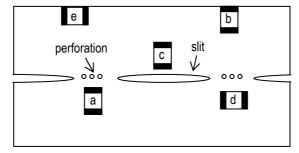
Improper circuit layout and pad/land size may cause excessive or not enough solder amount on the PC board. Not enough solder may create weak joint, and excessive solder may increase the potential of mechanical or thermal cracks on the ceramic capacitor. Therefore we recommend the land size to be as shown in the following table: 2.1 Size and recommend land dimensions for reflow soldering



EIA Code	Chip (mm)		Land (mm)				
EIA Code	L	W	Α	В	С	D	Е
0201	0.60	0.30	0.2~0.3	0.2~0.4	0.2~0.4		
0402	1.00	0.50	0.3~0.5	0.3~0.5	0.4~0.6		
0603	1.60	0.80	0.4~0.6	0.6~0.7	0.6~0.8		1
0805	2.00	1.25	0.7~0.9	0.6~0.8	0.8~1.1		1
1206	3.20	1.60	2.2~2.4	0.8~0.9	1.0~1.4	1.0~2.0	3.2~3.7
1210	3.20	2.50	2.2~2.4	1.0~1.2	1.8~2.3	1.0~2.0	4.1~4.6
1808	4.60	2.00	2.8~3.4	1.8~2.0	1.5~1.8	1.0~2.8	3.6~4.1
1812	4.60	3.20	2.8~3.4	1.8~2.0	2.3~3.0	1.0~2.8	4.8~5.3
1825	4.60	6.35	2.8~3.4	1.8~2.0	5.1~5.8	1.0~4.0	7.1~8.3
2208	5.70	2.00	4.0~4.6	2.0~2.2	1.5~1.8	1.0~4.0	3.6~4.1
2211	5.70	2.80	4.0~4.6	2.0~2.2	2.0~2.6	1.0~4.0	4.4~4.9
2220	5.70	5.00	4.0~4.6	2.0~2.2	3.5~4.8	1.0~4.0	6.6~7.1
2225	5.70	6.35	4.0~4.6	2.0~2.2	5.1~5.8	1.0~4.0	7.1~8.3

2.2 Mechanical strength varies according to location of chip capacitors on the P.C. board.
Design layout of components on the PC board such a way to minimize the stress imposed on the components, upon flexure of the boards in depanelization or other processes.

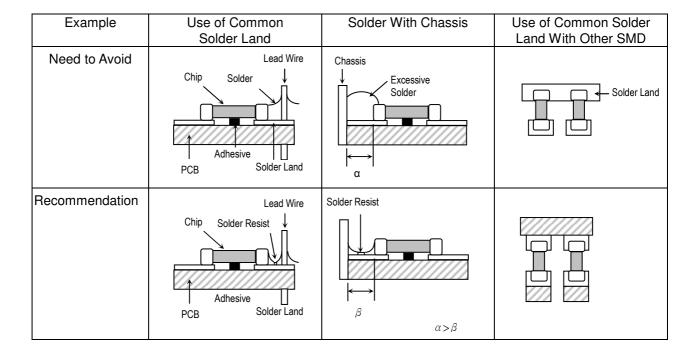
Component layout close to the edge of the board or the "depanelization line" is not recommended. Susceptibility to stress is in the order of: a>b>c and d>e



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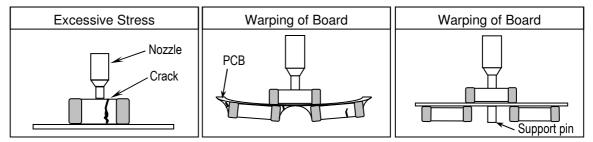


2.3 Layout Recommendation

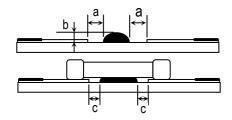


3. Mounting

3.1 Sometimes crack is caused by the impact load due to suction nozzle in pick and place operation. In pick and place operation, if the low dead point is too low, excessive stress is applied to component. This may cause cracks in the ceramic capacitor, therefore it is required to move low dead point of a suction nozzle to the higher level to minimize the board warp age and stress on the components. Nozzle pressure is typically adjusted to 1N to 3N (static load) during the pick and place operation.



3.2 Amount of Adhesive



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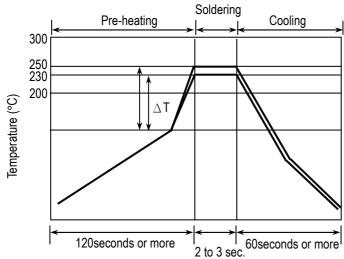


4. Soldering

4.1. Wave Soldering

Most of components are wave soldered with solder at 230 to $250\,^{\circ}$ C. Adequate care must be taken to prevent the potential of thermal cracks on the ceramic capacitors. Refer to the soldering methods below for optimum soldering benefits.

Recommend flow soldering temperature Profile



Soldering Method	Change in Temp.($^{\circ}\mathbb{C}$)
1206 and Under	$\Delta T \le 100 \sim 130 \text{ max}.$

To optimize the result of soldering, proper preheating is essential:

- 1) Preheat temperature is too low
 - a. Flux flows to easily
 - b. Possibility of thermal cracks
- 2) Preheat temperature is too high
 - a. Flux deteriorates even when oxide film is removed
 - b. Causes warping of circuit board
 - c. Loss of reliability in chip and other components

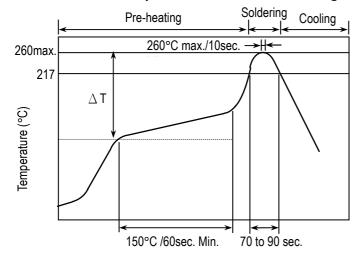
Cooling Condition:

Natural cooling using air is recommended. If the chips are dipped into a solvent for cleaning, the temperature difference (Δ T) between the solvent and the chips must be less than 100 °C.

4.2 Reflow Soldering

Preheat and gradual increase in temperature to the reflow temperature is recommended to decrease the potential of thermal crack on the components. The recommended heating rate depends on the size of component, however it should not exceed 3 °C/Sec.

Recommend reflow profile for Lead-Free soldering temperature Profile (MIL-STD-202G #210F)



★ The cycles of soldering : Twice (max.)

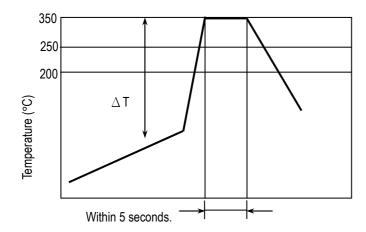
Soldering Method	Change in Temp.(°C)
1206 and Under	∆ T ≦ 190 °C
1210 and Over	∆ T ≦ 130 °C

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4.3 Hand Soldering

Sudden temperature change in components, results in a temperature gradient recommended in the following table, and therefore may cause internal thermal cracks in the components. In general a hand soldering method is not recommended unless proper preheating and handling practices have been taken. Care must also be taken not to touch the ceramic body of the capacitor with the tip of solder Iron.



Soldering Method	Change in Temp.($^{\circ}$ C)
1206 and Under	∆ T ≦ 150 °C
1210 and Over	Δ T \leq 130 $^{\circ}$ C

How to Solder Repair by Solder Iron

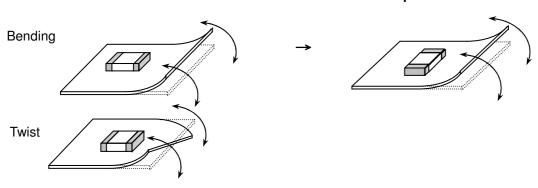
- 1) Selection of the soldering iron tip
 - The required temperature of solder iron for any type of repair depends on the type of the tip, the substrate material, and the solder land size.
- 2) recommended solder iron condition
 - a.) Preheating Condition: Board and components should be preheated sufficiently at 150 ℃ or over, and soldering should be conducted with soldering iron as boards and components are maintained at sufficient temperatures.
 - b.) Soldering iron power shall not exceed 30 W.
 - c.) Soldering iron tip diameter shall not exceed 3mm.
 - d.) Temperature of iron tip shall not exceed 350 °C to perform the process within 5 seconds. (refer to MIL-STD-202G)
 - f.) Do not touch the ceramic body with the tip of solder iron. Direct contact of the soldering iron tip to ceramic body may cause thermal cracks.
 - g.) After soldering operation, let the products cool down gradually in the room temperature.

5. Handling after chip mounted

5.1 Proper handling is recommended, since excessive bending and twist of the board, depends on the orientation of the chip on the board, may induce mechanical stress and cause internal crack in the capacitor.

Higher potential of crack

Lower potential of crack



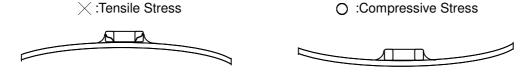
5.2 There is a potential of crack if board is warped due to excessive load by check pin



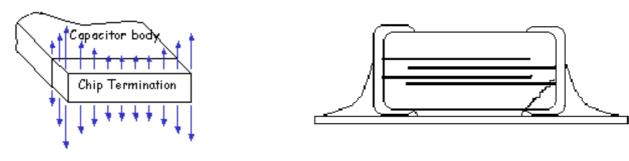
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- 5.3 Mechanical stress due to warping and torsion.
 - (a) Crack occurrence ratio will be increased by manual separation.
 - (b) Crack occurrence ratio will be increased by tensile force, rather than compressive force.



Capacitor Stress Analysis

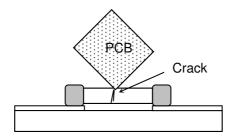


6. Handling of Loose Chip Capacitor

6.1 If dropped the chip capacitor may crack.



6.2 In piling and stacking of the P.C. boards after mounting for storage or handling, the corner of the P.C. board may hit the chip capacitor mounted on another board to cause crack.



7. Safekeeping condition and period

For safekeeping of the products, we recommend to keep the storage temperature between +5 to +40 °C and under humidity of 20 to 70% RH. The shelf life of capacitors is 12 months.

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NIN-FC2R7JTRF NMC0201X5R474K4TRPF NMC0402NPO220J50TRPF NMC0402X5R105K6.3TRPF NMC0402X5R224K6.3TRPF
NMC0402X7R103J25TRPF NMC0402X7R153K16TRPF NMC0603NPO1R8C50TRPF NMC0603NPO201J50TRPF
NMC0603NPO330G50TRPF NMC0603X5R475M6.3TRPF NMC0805NPO270J50TRPF NMC0805NPO820J50TRPF
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